

# HN613256P, HN613256FP

## 32768-word x 8-bit CMOS Mask Programmable Read Only Memory

The HN613256P/FP is a mask-programmable, byte-organized memory designed for use in bus-organized system.

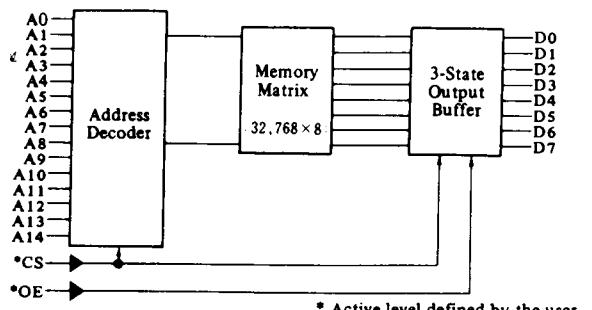
To facilitate use, the device operates from a single power supply, has compatibility with TTL, and requires no clocks or refreshing because of static operation.

The active level of the CS and OE input, and the memory content are defined by the user. The Chip Select input deselects the output and puts the chip in a power-down mode.

### ■ FEATURES

- Fully Static Operation
- Automatic Power Down
- Single +5V Power Supply
- Three-state Data Output for OR-ties
- Mask Programmable Chip Select and Output Enable
- TTL Compatible
- Maximum Access Time: 250ns
- Low Power Standby and Low Power Operation; Standby 5 $\mu$ W (typ.), Operation 50mW (typ.)
- Pin Compatible with EPROM

### ■ BLOCK DIAGRAM



### ■ ABSOLUTE MAXIMUM RATINGS

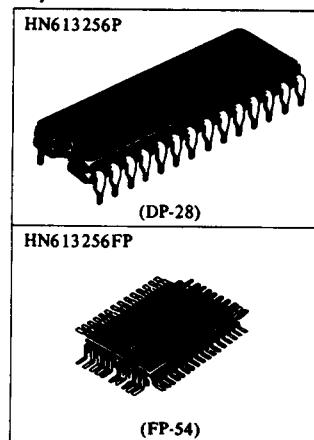
Item	Symbol	Value	Unit
Supply Voltage*	$V_{CC}$	-0.3 to +7.0	V
All Input and Output Voltage*	$V_T$	-0.3 to +7.0	V
Operating Temperature Range	$T_{opr}$	-20 to +75	°C
Storage Temperature Range	$T_{stg}$	-55 to +125	°C
Storage Temperature Range (Under Bias)	$T_{bias}$	-20 to +85	°C

\*With respect to  $V_{SS}$

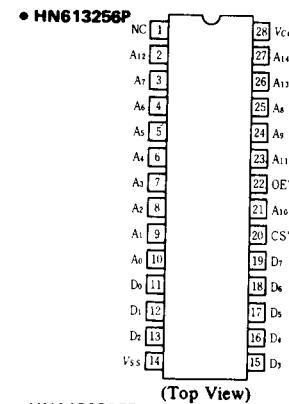
### ■ RECOMMENDED DC OPERATING CONDITIONS

Item	Symbol	min.	typ.	max.	Unit
Supply Voltage*	$V_{CC}$	4.5	5.0	5.5	V
Input Voltage*	$V_{IL}$	-0.3	—	0.8	V
	$V_{IH}$	2.2	—	$V_{CC}$	V
Operating Temperature	$T_{op}$	-20	—	75	°C

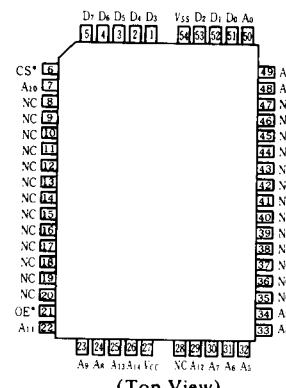
\* With respect to  $V_{SS}$ .



### ■ PIN ARRANGEMENT



• HN613256FP



■ ELECTRICAL CHARACTERISTICS ( $V_{CC} = 5.0V \pm 10\%$ ,  $V_{SS} = 0V$ ,  $T_a = -20 \sim +75^\circ C$ )

Item	Symbol	Test Condition	min	typ	** max	Unit
Input Voltage	$V_{IH}$		2.2	-	$V_{CC}$	V
	$V_{IL}$		-0.3	-	0.8	V
Output Voltage	$V_{OH}$	$I_{OH} = -205 \mu A$	2.4	-	-	V
	$V_{OL}$	$I_{OL} = 3.2 mA$	-	-	0.4	V
Input Leakage Current	$I_{LI}$	$V_{in} = 0 \sim 5.5V$	-	-	2.5	$\mu A$
Output Leakage Current	$I_{LOH}$	$CS = 0.8V$ , $CS = 2.2V$	$V_{out} = 2.4V$	-	-	$\mu A$
	$I_{LOL}$		$V_{out} = 0.4V$	-	-	$\mu A$
Supply Current	Active	$V_{CC} = 5.5V$ , $I_{out} = 0mA$ , $t_{RC} = \text{min}$ , duty = 100%.	-	15	30	mA
	Standby	$V_{CC} = 5.5V$ , $CS \geq V_{CC} - 0.2V$ , $CS \leq 0.2V$	-	1	30	$\mu A$
Input Capacitance	$C_{in}^{***}$		-	-	10	pF
Output Capacitance	$C_{out}^{***}$	$V_{in} = 0V$ , $f = 1 MHz$ , $T_a = 25^\circ C$	-	-	15	pF

\* Steady state current    \*\*\* This parameter is sampled and not 100% tested.  
\*\*  $V_{CC} = 5V$ ,  $T_a = 25^\circ C$

■ AC CHARACTERISTICS (READ CYCLE)

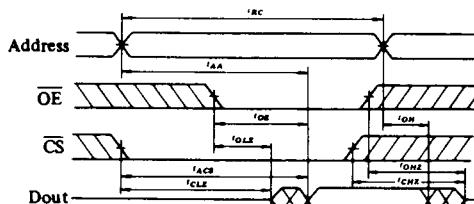
( $V_{CC} = 5V \pm 10\%$ ,  $V_{SS} = 0V$ ,  $T_a = -20 \sim +75^\circ C$ ,  $t_s = t_f = 20ns$ )

Item	Symbol	min	max	Unit
Read Cycle Time	$t_{RC}$	250	-	ns
Address Access Time	$t_{AA}$	-	250	ns
Chip Select Access Time	$t_{ACS}$	-	250	ns
Chip Selection to Output in Low Z	$t_{CLZ}$	10	-	ns
Output Enable to Output Valid	$t_{OE}$	-	100	ns
Output Enable to Output in Low Z	$t_{OLZ}$	10	-	ns
Chip Deselection to Output in High Z	$t_{CHZ}$	0	100	ns
Output Disable to Output in High Z	$t_{OHZ}$	0	100	ns
Output Hold from Address Change	$t_{OH}$	10	-	ns

\*  $t_{AA}$  and  $t_{OLZ}$  defines the time at which the output achieves the open circuit condition and is not reference to output voltage levels.

■ TIMING WAVEFORM

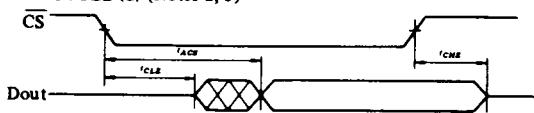
• READ CYCLE (1)



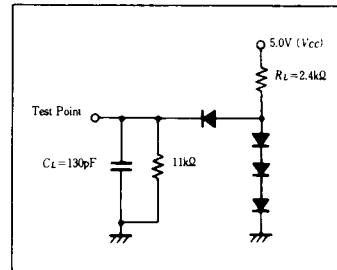
• READ CYCLE (2) (Notes 1, 3)



• READ CYCLE (3) (Notes 2, 3)



• AC TEST LOAD



- Notes : 1.  $t_s = t_f = 20ns$   
2.  $C_L$  includes jig capacitance  
3. All diodes are 1S2074④

NOTES:

1. Device is continuously selected.
2. Address Valid prior to or coincident with CS transition low.
3.  $OE = V_{IL}$ .
4. Input pulse level: 0.8 to 2.4V
5. Input and output reference level: 1.5V